


<b>Search Notes</b>  	<b>Application/Control No.</b>  10821123	<b>Applicant(s)/Patent Under Reexamination</b>  LITTLE ET AL.
	<b>Examiner</b>  PHUC H TRAN	<b>Art Unit</b>  2416

SEARCHED			
Class	Subclass	Date	Examiner
600	437,441,446,459,437,440	04/02/2008	MC
370	Hybrid	04/02/2008	MC
same as above	same as above	10/29/08	MC

SEARCH NOTES		
Search Notes	Date	Examiner
East (All DBs)	04/02/2008	MC
Consult - Huy Vu, Daniel Ryman	04/02/2008	MC
same as above	10/29/08	MC
Consulted with Steven Nguyen	8/24/2009	pt
Consulted with Chi Pham	8/20/2009	pt
East updated search		

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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